

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS : Jong-Cheol Lee, et al. ATTY DOCKET NO. : 8836-223 (ID12244-US)
SERIAL NO. : 10/748,906 EXAMINER : Saqib Javaid Siddiqui
FILED : December 30, 2003 ART UNIT : 2138
TITLE : SEMICONDUCTOR MEMORY DEVICE TESTABLE WITH A SINGLE DATA RATE AND/OR DUAL DATA RATE PATTERN IN A MERGED DATA INPUT/OUTPUT PIN TEST MODE

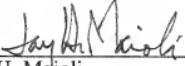
MAIL STOP: AMENDMENT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE TO NOTICE OF NON-COMPLIANT AMENDMENT

SIR :

In response to the Notice of Non-Compliant Amendment, applicants respectfully re-submit the Amendment in response to the Official Action of November 24, 2006, herewith, with the corrections as suggested by the Examiner.

Respectfully submitted,



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Dated: May 2, 2007

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